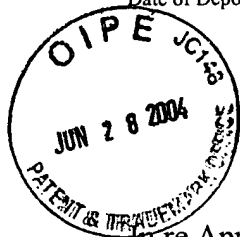


"Express Mail" mailing label number EV 314 901 878 US

Date of Deposit: June 28, 2004



Infineon Ref. No. P26985

Our Case No. 10808/109

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

E. Steinkirchner et al.

Serial No. 10/712,418

Filing Date: November 12, 2003

For METHOD, PREPARATIONS,  
COMPUTER LEGIBLE AGENT AND  
COMPUTER PROGRAM ELEMENT  
FOR THE CALCULATED SUPPORT  
CONTROL OF PROCESS  
PARAMETERS FOR PHYSICAL  
OBJECTS

Examiner: Unknown

Group Art Unit No. Unknown

### INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents  
Alexandria, VA 22313-1450

Dear Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56, it is respectfully requested that this Information Disclosure Statement be entered and the documents listed below and on the attached Form PTO-1449 be considered by the Examiner and made of record. Copies of the listed documents required by 37 C.F.R. § 1.98(a)(2) are enclosed for the convenience of the Examiner.

The references now cited are the following:

## U.S. PATENTS

<u>Document No.</u>	<u>Date</u>	<u>Inventor</u>
5,586,041	12/17/1996	Mangrulkar
5,726,920	03/10/1998	Chen et al.
2002/0055194 A1	05/09/2002	Takanabe

## FOREIGN PATENT DOCUMENTS

<u>Document No.</u>	<u>Date</u>	<u>Country</u>
GB 2 283 116 A	04/26/1995	United Kingdom

## OTHER ART

Copy of European Search Report dated March 10, 2004 for European Patent Application No. 03026035

C. Schneider et al., "Automated Photolithography Critical Dimension Controls In A Complex, Mixed Technology, Manufacturing Fab", IBM Microelectronics, 2001 IEEE/SEMI Advanced Semiconductor Manufacturing Conference

In accordance with 37 C.F.R. § 1.97(g),(h), this Information Disclosure Statement is not to be construed as a representation that a search has been made and is not to be construed to be an admission that the information cited is, or is considered to be, material to patentability as defined in 37 C.F.R. § 1.56(b).

This Information Disclosure Statement is being filed prior to the receipt of the first Official Action reflecting an examination on the merits and hence is believed to be timely filed in accordance with 37 C.F.R. § 1.97(b). No fees are believed to be due in connection with filing of this Information Disclosure Statement, however, should any fees under 37 C.F.R. §§ 1.16 to 1.21 be deemed necessary for any reason relating to these material, the Commissioner is hereby authorized to deduct said fees from Brinks Hofer Gilson & Lione Deposit Account No. 23-1925. A duplicate copy of this document is enclosed.

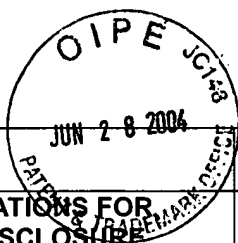
Applicant(s) respectfully request that the listed documents be made of record in the present case.

Respectfully submitted,

A handwritten signature in black ink, appearing to read "J. King", is written over a horizontal line.

John J. King  
Registration No. 35,918  
Attorney for Applicant(s)

BRINKS HOFER GILSON & LIONE  
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Chicago, IL 60610  
(312) 321-4200



FORM PTO-1449	SERIAL NO. 10/712,418	CASE NO. 10808/109
<b>LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT</b>	FILING DATE November 12, 2003	GROUP ART UNIT Unknown
(use several sheets if necessary)		APPLICANT(S): E. Steinkirchner et al.

**REFERENCE DESIGNATION U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	A1	5,586,041	12/17/1996	Mangrulkar		
	A2	5,726,920	03/10/1998	Chen et al.		
	A3	2002/0055194 A1	05/09/2002	Takanabe		

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
	A4	GB 2 283 116 A	04/26/1995	United Kingdom		

EXAMINER INITIAL	<b>OTHER ART – NON PATENT LITERATURE DOCUMENTS</b> <small>(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.)</small>	
	A5	Copy of European Search Report dated March 10, 2004 for European Patent Application No. 03026035
	A6	C. Schneider et al., "Automated Photolithography Critical Dimension Controls In A Complex, Mixed Technology, Manufacturing Fab", IBM Microelectronics, 2001 IEEE/SEMI Advanced Semiconductor Manufacturing Conference

EXAMINER	DATE CONSIDERED
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.